

KONICA MINOLTA Group

VCSEL Characterization -Polarization and Eye Safety

Dr. Karthik lyer 13-06-22



Premium German Quality in Light & Display Measurement.

MicroLED Quantum Dots OLED UV-LED AR/VR Glasses Blue Light Hazard AR/VR Glasses We bring Quality to Light

Flat Panel Display Smart Devices Laser IR

Automotive Interior Vehicle Headlights SSL Luminaires Head Up Displays

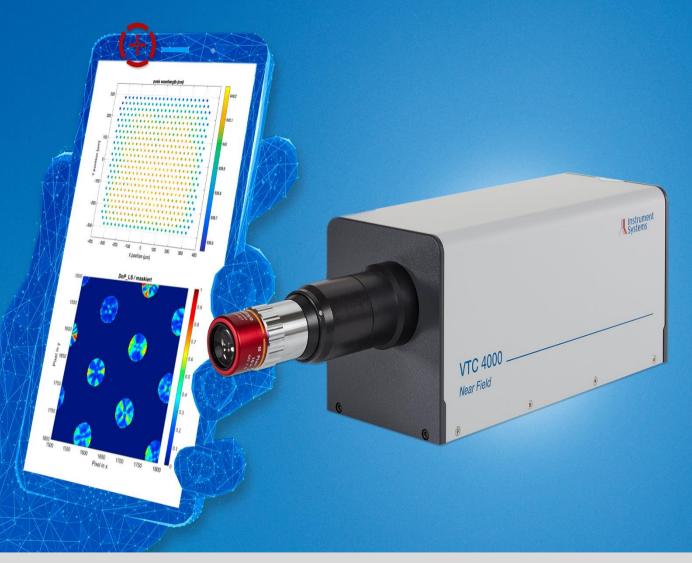
Global Sales Network and Service Teams.





Vcsel Testing Camera 4000

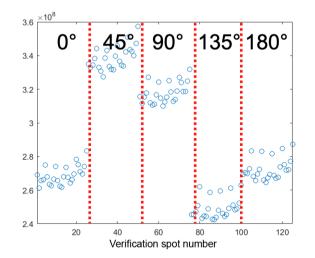
One-Shot Single Emitter Characterization on a VCSEL Array including polarization properties

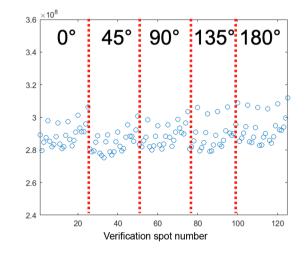




Importance of characterizing polarization dependency

For absolute power measurements of the emitter power of the VCSEL, e.g. for eye safety, it is important to take these effects into account, otherwise the read-out value is incorrect.



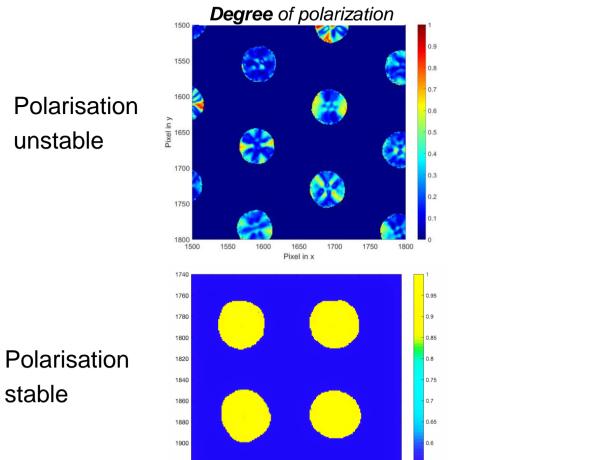


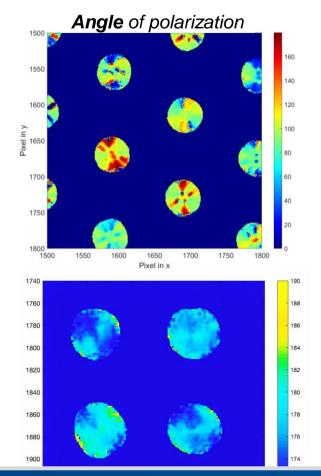
Comparison of total power measurement with different polarizations, each dot represents one measurement position. Measurement done with rotating the source in 45° steps

The same measurement as shown in the left, but corrected for polarization effects. The intensity does not show any polarization effects anymore and can be calculated back to Watt independent of the polarization of the incoming light.



Polarization Analysis with VTC 4000





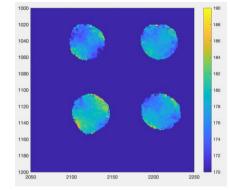
This solution can be very helpful for the researchers as well as for VCSEL manufacturers to characterize/analyze polarization controlling techniques

Polarization characterization and Eye safety classification

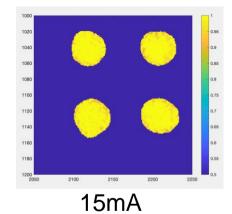


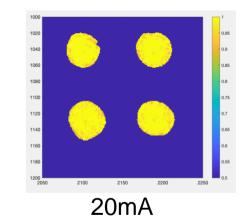
Results

Polarization Angle



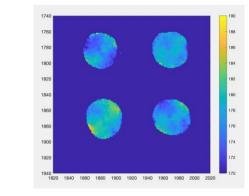
Polarization Degree

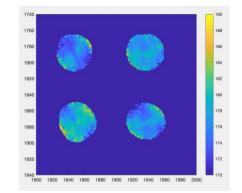


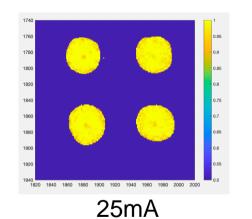


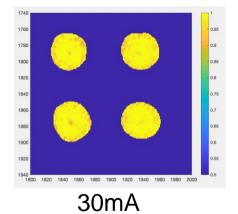
2150

2200









Polarization characterization and Eye safety classification

Dr. Karthik Suresh lyer



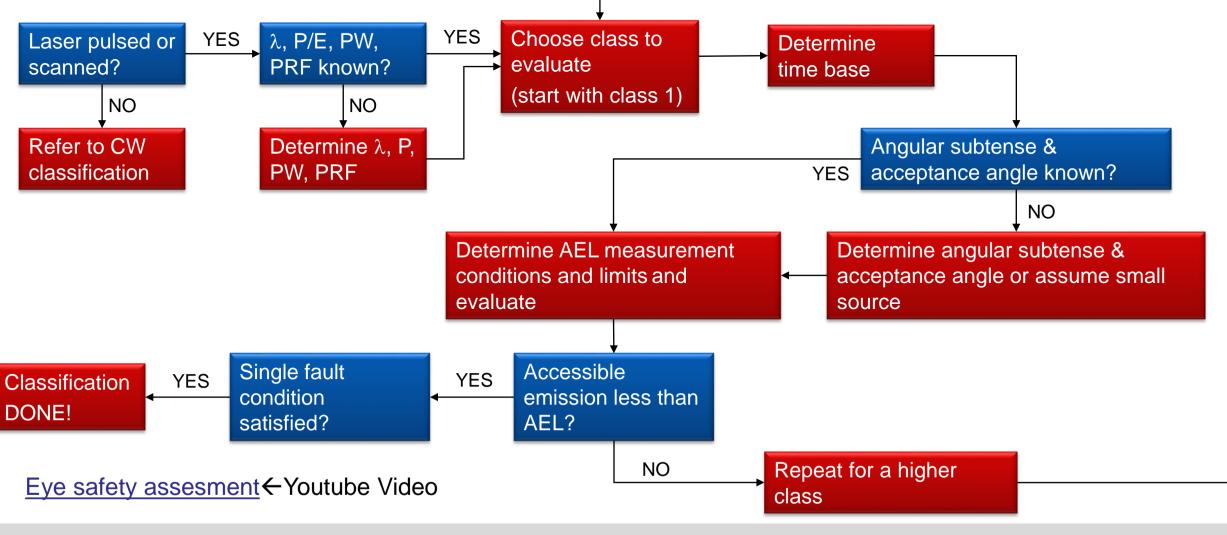
▲ Laser light ഐ Coherent and strongly directed, great potential to destroy retina, lens or cornea lla Eye-Safety Laser Eye Safety

Determine the fraction of laser light absorbed in the eye ball or imaged onto the retina

Polarization characterization and Eye safety classification



Laser Class Assessment: Flowchart

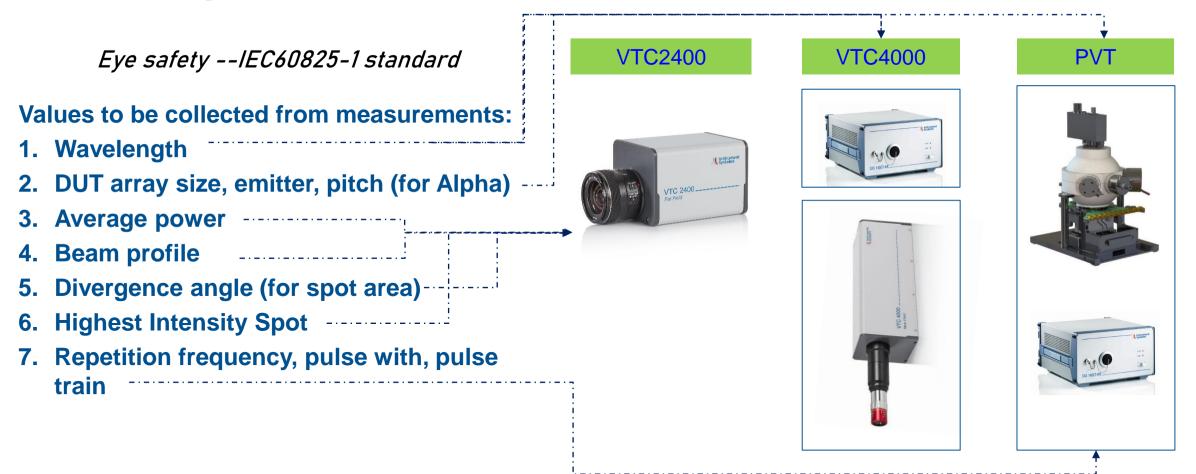


Polarization characterization and Eye safety classification





Data acquisition and measurement device

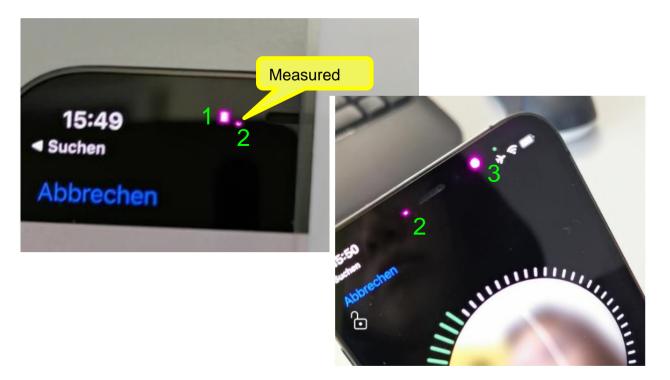




NIR Light source from a commercial IPhone 12 pro

• Front:

3 sources observed



• Back:

1 dot projector observed





Example : Iphone12pro front light source

Far-Field: VTC2400	Pulse Analysis: PVT	Spectral Analysis: HR-CAS	Near-Field: VTC4000
Technology: 2D camera with transparent	Technology: Spectrometer with integrating	Technology: Spectrometer with integrating	<u>Technology</u> : 2D camera with microscopic
screen	sphere, driving electronics and fast photodiode	sphere and optional photodiode	optics
Parameters: Beam Profile	Parameters:	Parameters:	Paramters:
 Divergence Angle 	 Pulse width, Pulse train, 	 Wavelength 	 Pitch
 Hot Spot detection (Max Power) 	DCPower, Wavelength	 Peak Power 	 Beam quality
Julius Julius			x-axis: 1956-1715=241 y-axis: 1588-1343=245
		250	1590 -
	The state of the s		1450 - Later 1400 -
↓ ↓		91 92 93 94 95 93 95 93 99	1350 0 100 100 100 100

PLUS NIST or PTB traceable calibration with known error budget

Instrument Systems

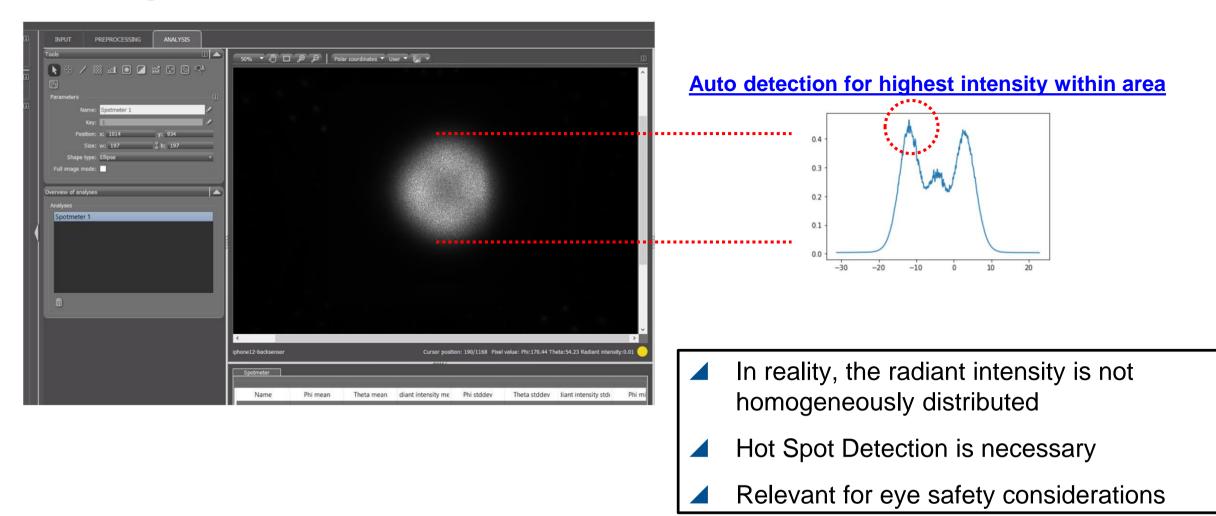
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Hot Spot Detection in Lumisuite Software with VTC2400





Calculations

Parameter							
Messung mit PVT, VTC2400, VTC4000	Geometrische Berechnungen	Konstanten und Korekturfaktoren lt. Norm	LaserEyeSafetyTool	Transfer			
		TI (040 40		Inputs			
lambda 934.40000000 nm	D_eye(940nm) 0.007000000 m => A eye 0.000038485 m ²	Timebase(940mn 10 s	Controls	DUT Parameters			
t_pulse 0.000015000000 s p peak 0.006003493 W	=> A_eye 0.000038485 m ² D min 0.10000000 m	C4 2.94306599 C6 0.277149984		Wavelength	934,00 nm		
t burst 0.01000000 s	A_spot (D_min) 0.000347049 m^2	T_i 0.000005 s	Instrument Systems	Average Power	0,00 W		
	A_spot/A_eye 9.017877772	-		Don't know DUT size			
=> T 0.00001700000			KONICA MINOLTA Group				
DC_burst 0.029411765	- "	-	Calculate	DUT Size X	0,00 um		
Divergence 24.00000000 °	P_eff 0.000665732 Ausgedehnte Quelle	-		DUT Size Y	0,00 um		
=>Div_rad 0.209439510	alpha_x 0.000415725 rad		-	Pulse Parameters			
=>DUT X 0.000083145 m	alpha_y 0.000422625 rad						
=> DUT Y 0.000084525 m	alpha_min 0.001500000 rad		-	Laser Pulse Type	Single Pulse V		
	(beachte für alpha < alpha min: C6=1)			Single Pulse, Pulse Width	1,00 ns		
				Single Pulse, Period	1,00 ns		
1. Single Pulse Kriterium (S.27)	2. Mittlere Leistung nach 5µs, 2ms und 10s (S.27)	3. Reduziertes Einzelpulskriterium (S.27)		Pulse Train Width	0,00 ns		
E_pulse 9.98599E-09	N(T_i) 0.294117647	C5(T_i) 1 (N<600,Tpulse <ti)< th=""><th>-</th><th>Pulse Train, Period</th><th>0,00 ns</th></ti)<>	-	Pulse Train, Period	0,00 ns		
E_SP_MPE 6.28066E-08	P_avg(T_i) 0.000587411	C5(t_burst) 86.660938 (N<600,Tpulse <ti)< th=""><th>m m</th><th>Pulse Train Burst Width</th><th>0,00 ns</th></ti)<>	m m	Pulse Train Burst Width	0,00 ns		
	P_avg_MPE 0.012561329	C5(Timebase) 624.8475007	-				
-	N(t burst) 588.235294118		-	Pulse Train Burst Period	0,00 ns		
	P_avg(t_burst) 0.000587411	E_pulse_Tburst 9.98599E-09	-	Average Power in 7mm Spot at 100mm Distance			
1	P_avg_MPE 0.001805564	E_pulse_Timaba 9.98599E-09	-	Average Power unknown (Total Power will be use	ed		
			-	Average Power at 7mm Spot	0,00 W		
-	N(Timebase) 17301.038062284 P_avg(t_Timeba: 0.000017277	E_SP_MPE_Ti 6.28066E-08 E_SP_MPE_tburst 5.44288E-06	-	Average Power at min spot	0,00 W		
	P_avg_MPE 0.000321080	E SP MPE Timb: 3.92446E-05	-	Lacer Class 1.0K2			
	PLR	PLR		Laser Class 1 OK!			
	T_i 0.046763440	T_i 0.158995695					
	t_burst 0.325333757	t_burst 0.001834687	-				
	t_Timebase 0.053808416	t_Timebase 0.000254455	-				
	•						
Manual Ca	alculation 🕈						
ivianuai Ge	alculation				LASER CLASS 1		
Classified as Class 1 Laser							
LaserEyeSafety Tool							



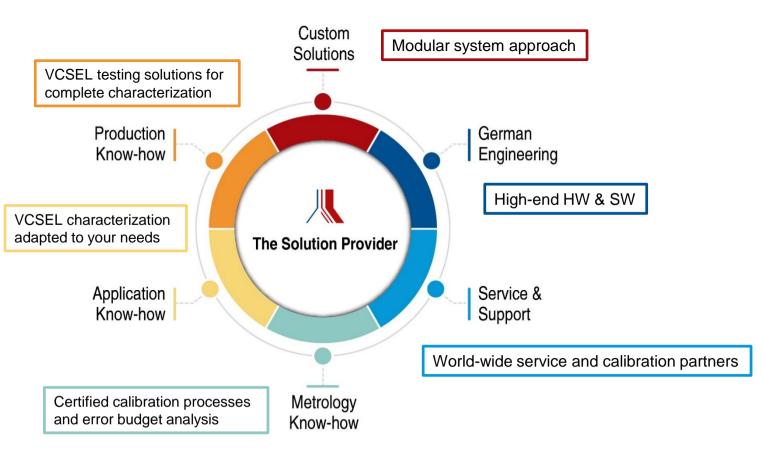
Take Home Message

- ▲ VCSELs are lasers and must comply with the IEC60825-1 standard
- ▲ As compared to "normal" lasers they are
 - Multimode / Irregular
 - Divergent
 - Often Extended
 - Often Pulsed
- Worst case assumptions can reduce effort (complex measurements and analytics), however, may lead to restricted AELs

Choose calibrated and traceable measurement equipment that satisfies IEC 61040 !



Thank you for your attention



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